	Application No.	Applicant(s)
Notice of Allowability Ex	09/922,973	BLOOMSTEIN ET AL.
	Examiner	Art Unit
	Kripa Sagar	1756
	Klipa Sagai	1730
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in or other appropriate commul GHTS. This application is su	this application. If not included nication will be mailed in due course. THIS
1. \boxtimes This communication is responsive to <u>5/17/04</u> .		
2. X The allowed claim(s) is/are 1-11,13-23 and 25-27.		
3. \boxtimes The drawings filed on <u>10 October 2003</u> are accepted by the	e Examiner.	
4. ☐ Acknowledgment is made of a claim for foreign priority un a) ☐ All b) ☐ Some* c) ☐ None of the:		r (f).
1. Certified copies of the priority documents have		. N.
2. Certified copies of the priority documents have	• •	· · · · · · · · · · · · · · · · · · ·
 Copies of the certified copies of the priority doc International Bureau (PCT Rule 17.2(a)). 	cuments have been received	in this national stage application from the
* Certified copies not received:		
•		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a ENT of this application.	a reply complying with the requirements
5. A SUBSTITUTE OATH OR DECLARATION must be submi INFORMAL PATENT APPLICATION (PTO-152) which give	tted. Note the attached EXAI is reason(s) why the oath or	MINER'S AMENDMENT or NOTICE OF declaration is deficient.
6. CORRECTED DRAWINGS (as "replacement sheets") mus	t be submitted.	
(a) I including changes required by the Notice of Draftsperso	on's Patent Drawing Review	(PTO-948) attached
1) ☐ hereto or 2) ☐ to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	Amendment / Comment or i	n the Office action of
Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the	84(c)) should be written on the ne header according to 37 CFR	edrawings in the front (not the back) of the control of the contro
 DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT F 	SIT OF BIOLOGICAL MATE FOR THE DEPOSIT OF BIOI	RIAL must be submitted. Note the LOGICAL MATERIAL.
Attachment(s)		
1. Notice of References Cited (PTO-892)	_	ormal Patent Application (PTO-152)
2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ☐ Interview Sui Paper No./N	mmary (PTO-413), ⁄lail Date
 Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date 		Amendment/Comment
4. Examiner's Comment Regarding Requirement for Deposit		Statement of Reasons for Allowance
of Biological Material	9. 🗌 Other	
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Application/Control Number: 09/922,973

Art Unit: 1756

DETAILED ACTION

Response to Amendment

1. The amendment filed 5/17/04 has been entered. Claims 1,4,6 have been amended. Claims 14-27 are newly added. No new matter has been introduced. Claim 12 is cancelled.

Claims 1-11,13-27 are under consideration.

EXAMINER'S AMENDMENT

2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with attorney Tom Engellenner on 7/20/04.

The application has been amended as follows:

In the claims:

Claim 13, last line: replace the term "smaller" with "decreasing".

Claim 23, last line: replace the phrase ", using the smaller spot size to expose the buffer region." with the following: "; wherein the buffer region is patterned with a spot size larger than a spot size used in a critical region and smaller than the maximum spot size used in an interior region."

Cancel claim 24.

Claims 1-11,13-23,25-27 are under consideration.

Allowable Subject Matter

- 3. Claims 1-11,13-23,25-27 are allowed.
- 4. The following is an examiner's statement of reasons for allowance:

The amended claims 1,13 and new claims 14,23 recite an intermediate spot size to expose a buffer zone; this is not taught in the cited references. Claim 6 recites varying the spot size while maintaining the scanning speed. This is not discussed in the cited references.

As argued by the Applicant this has several advantages not discussed in the prior art. These include speedier patterning and elimination of edge effects. The claims are based on modulation of a beam with a Gaussian or an Airy-disk intensity distribution. None of the cited references considers beam profiling.

US Pat.5623473 to Ichihara discusses modulating a beam to produces a diffraction grating zone plate wherein the resist profile is formed by adjusting the exposure dose. The beam size is accordingly modulated. It does not teach multiple spot sizes.

US Pat. 6406658 to Manners et al. teaches spot-size modulated patterning in stereolithography – it discusses multiple spot sizes (abstract & fig.5). However there are no defined zones and the beams of different sizes are used in overlapping zones.

5. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Response to Arguments

6. Applicant's arguments have been considered in allowing the claims.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kripa Sagar whose telephone number is 571-272-1392. The examiner can normally be reached on M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mark F Huff can be reached on 571-272-1385. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MH/ks

MARK F. HUFF SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700

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